Wurth Electronics Midcom Inc.
121 Airport Drive ·P.O. Box 1330 · Watertown SD
57201-6330, USA
T: +1 (605) 886 4385 · Toll Free: +1 (800) 643 2661
www.we-online.com

WÜRTH ELEKTRONIK

Product / Process Change Notification (PCN)

☒ Major change
☐ Minor change

		Change Category:
PCN #:	PCN_UtMID_20190531	☐ Equipment / Location
Affected Series:	UT_MID	☐ General Data
		☒ Material
PCN Date:	March 01, 2019	☐ Process
Effective Date:	May 31, 2019	☐ Product Design
		☐ Shipping / Packaging
		☐ Supplier
First effected Lot Code:	Date code 1923	☐ Software
Last non-effected Lot Code:		
Revision:	See Below	

		Data Sheet Change:
Contact:	Design Engineering Coordinator	☐ Yes ☒ No
Phone:	+1 (605) 884 2443	**Attachment:**
Fax:	+1 (605) 886 4486	
E-Mail:	pcn.midcom@we-online.com	☐ Yes ☒ No

DESCRIPTION AND PURPOSE OF CHANGE:

Due to external influences, Wurth Electronics Midcom will change the epoxy securing coil to header. The existing epoxy has gone end of life and supply is limited. Part number and revisions will change as stated:

750315229 6B to 6C

750315230 6B to 6C

750315231 6B to 6C

750315232 6B to 6C

750316552 6A to 6B

750317011 6B to 6C

750317269 6A to 6B

750317490 6A to 6B

750342879 6C to 6D

750370165 6A to 6B

750370171 6B to 6C

DETAIL OF CHANGE:

Change the epoxy used to secure coil to header from Hysol EE1068 + HD3942 to Eccobond G500 due to supplier obsolescence.

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RELIABILITY / QUALIFICATION SUMMARY:

- Moisture Resistance: Reference Standard: MIL-STD-202G, Method 106;
- Resistance to Soldering Heat: Reference Standard: MIL-STD-202G, Method 210, @ 260±5℃/10±1s;
- Thermal Shock: Reference Standard: MIL-STD-202G, Method 107, @ (-40℃ ~ 125℃） 300cycles
- Mechanical Vibration: Reference Standard: MIL-STD-202G, Method 204, @10-2000 Hz 5g's fo20 minutes, 12 cycles;
- Mechanical Shock: Reference Standard: MIL-STD-202G Method 213, Condition C;